

<b>Notice of References Cited</b>	Application/Control No. 10/815,420	Applicant(s)/Patent Under Reexamination JIN, HWAIL	
	Examiner Daniel Zirker	Art Unit 1771	Page 1 of 1

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*	B	US-2005/0227064 A1	10-2005	Jin, Hwail	428/343
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	K	US-			
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	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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